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Homs ru

FCC REPORT

Report Reference No.....: TRE17100075 R/C.....: 67047

FCC ID.....: SVC-HP70

Applicant's name.....: Lenbrook Industries Limited

Manufacturer...... Wata Electronics Co., Ltd.

Guangdong, China

Test item description: Bluetooth Headphone

Trade Mark: NAD

Model/Type reference...... HP70

Listed Model(s) -

Standard: 47 CFR FCC Part 15 Subpart B

Date of receipt of test sample........... Oct. 17, 2017

Date of testing...... Oct. 17, 2017 - Oct. 27, 2017

Date of issue...... Oct. 27, 2017

Result...... Pass

Compiled by

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(position+printed name+signature)..: RF Manager Hans Hu

Testing Laboratory Name: Shenzhen Huatongwei International Inspection Co., Ltd.

Tianliao, Gongming, Shenzhen, China

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1. Test standards and Report version

1.1. Test Standards

The tests were performed according to following standards:

47 CFR FCC Part 15 Subpart B - Unintentional Radiators

<u>ANSI C63.4: 2014</u> – American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40GHz

1.2. Report version

Version No.	Date of issue	Description
00	Oct. 27, 2017	Original

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2. Test Description

Test Item	Section in CFR 47	Result
Conducted Emissions	15.107(a)	Pass
Radiated Emissions	15.109(a)	Pass

Note: The measurement uncertainty is not included in the test result.

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3. Summary

3.1. Client Information

Applicant:	Lenbrook Industries Limited
Address: 633 Granite Court, Pickering, Ontario L1W 3K1, Canada	
Manufacturer:	Wata Electronics Co., Ltd.
Addroso	No 142, South Tanshen Road, Tanzhou Town, Zhongshan City,
Address:	Guangdong, China

3.2. Product Description

Name of EUT	Bluetooth Headphone
Trade Mark:	NAD
Model No.:	HP70
Listed Model(s):	-
Power supply:	AC 120V/60Hz
Adapter information:	-

3.3. EUT operation mode

The EUT was tested stand-alone.

The EUT has been tested under communication with PC by USB mode.

3.4. EUT configuration

The following peripheral devices and interface cables were connected during the measurement:

supplied by the manufacturer

\circ	-	sui	or	olie	d	bv	the	lab

\circ	PC	Manufacturer:	DELL
		Model No.:	OptiPlex 3020 MT
\circ	Monitor	Manufacturer:	DELL
		Model No.:	E1912Hf
\circ	Keyboard	Manufacturer :	DELL
		Model No.:	SK8115
\circ	Mouse	Manufacturer:	DELL
		Model No.:	MS111-T
\circ	Printer	Manufacturer:	EPSON
		Model No.:	L101

Note: Peripheral devices comply with FCC DOC approval.

3.5. Configuration of Tested System

EUT	

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4. Test Environment

4.1. Address of the test laboratory

Laboratory: Shenzhen Huatongwei International Inspection Co., Ltd.
Address: 1/F, Bldg 3, Hongfa Hi-tech Industrial Park, Genyu Road, Tianliao, Gongming, Shenzhen, China Phone: 86-755-26748019 Fax: 86-755-26748089

4.2. Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

CNAS-Lab Code: L1225

Shenzhen Huatongwei International Inspection Co., Ltd. has been assessed and proved to be in compliance with CNAS-CL01 Accreditation Criteria for Testing and Calibration Laboratories (identical to ISO/IEC17025: 2005 General Requirements) for the Competence of Testing and Calibration Laboratories.

A2LA-Lab Cert. No. 3902.01

Shenzhen Huatongwei International Inspection Co., Ltd. EMC Laboratory has been accredited by A2LA for technical competence in the field of electrical testing, and proved to be in compliance with ISO/IEC 17025: 2005 General Requirements for the Competence of Testing and Calibration Laboratories and any additional program requirements in the identified field of testing.

FCC-Registration No.: 762235

Shenzhen Huatongwei International Inspection Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. Registration 762235.

IC-Registration No.: 5377B-1

Two 3m Alternate Test Site of Shenzhen Huatongwei International Inspection Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for the performance of radiated measurements with Registration No. 5377B-1.

ACA

Shenzhen Huatongwei International Inspection Co., Ltd. EMC Laboratory can also perform testing for the Australian C-Tick mark as a result of our A2LA accreditation.

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4.3. Equipments Used during the Test

Cond	Conducted Emissions						
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal		
1	EMI Test Receiver	Rohde & Schwarz	ESCI	101247	2016/11/13		
2	Artificial Mains	Rohde & Schwarz	NNLK 8121	573	2016/11/13		
3	Pulse Limiter	Rohde & Schwarz	ESH3-Z2	101488	2016/11/13		
4	Test cable	ENVIROFLEX	3651	1101902	2016/11/13		
5	Test Software	Rohde & Schwarz	ES-K1	N/A	N/A		

Radia	Radiated Emissions						
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Last Cal		
1	Ultra-Broadband Antenna	ShwarzBeck	VULB9163	538	2016/11/13		
2	Horn Antenna	Rohde&Schwarz	HF906	100039	2016/11/13		
3	Amplifer	ShwarzBeck	BBV 9743	9743-0022	2016/11/13		
4	Test cable	Siva Cables Italy	RG 58A/U	W14.02	2016/11/13		
5	EMI Test Receiver	Rohde & Schwarz	ESCI	101247	2016/11/13		
6	Turntable	MATURO	TT2.0		N/A		
7	Antenna Mast	MATURO	TAM-4.0-P-12		N/A		
8	EMI Test Software	Rohde & Schwarz	ESK1	N/A	N/A		
9	EMI Test Software	Audix	E3	N/A	N/A		

The calibration interval was one year.

4.4. Environmental conditions

During the measurement the environmental conditions were within the listed ranges:

2 411119 4110 1110 44041 01111 01111 01111 011441 00114141 0110 11141 111 11				
Temperature:	15~35°C			
lative Humidity:	30~60 %			
Air Pressure:	950~1050mba			

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4.5. Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to CISPR 16 - 4 "Specification for radio disturbance and immunity measuring apparatus and methods – Part 4: Uncertainty in EMC Measurements" and is documented in the Shenzhen Huatongwei International Inspection Co., Ltd quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Hereafter the best measurement capability for Shenzhen Huatongwei laboratory is reported:

Test	Range	Measurement Uncertainty	Notes
Radiated Emissions	30~1000MHz	4.24 dB	(1)
Radiated Emissions	1~18GHz	5.16 dB	(1)
Radiated Emissions	18-40GHz	5.54 dB	(1)
Conducted Disturbance	0.15~30MHz	3.39 dB	(1)

⁽¹⁾ This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

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5. Test Conditions and Results

5.1. Conducted Emissions Test

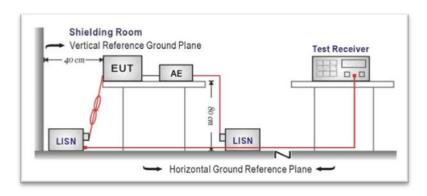
LIMIT

FCC CFR Title 47 Part 15 Subpart B Section 15.107:

Frequency range (MHz)	Limit (dBuV)	
	Quasi-peak	Average
0.15-0.5	66 to 56*	56 to 46*
0.5-5	56	46
5-30	60	50

^{*} Decreases with the logarithm of the frequency.

TEST CONFIGURATION



TEST PROCEDURE

- 1. The EUT was setup according to ANSI C63.4:2014 for compliance to FCC 47CFR 15.247 requirements.
- 2. The EUT was placed on a plat form of nominal size, 1 m by 1.5 m, raised 10 cm above the conducting ground plane. The vertical conducting plane was located 40 cm to the rear of the EUT. All other surfaces of EUT were at least 10 cm from any other grounded conducting surface.
- 3. The EUT and simulators are connected to the main power through a line impedance stabilization network (LISN). The LISN provides a 50ohm / 50uH coupling impedance for the measuring equipment.
- 4. The peripheral devices are also connected to the main power through a LISN. (Please refer to the block diagram of the test setup and photographs)
- 5. Each current-carrying conductor of the EUT power cord, except the ground (safety) conductor,was individually connected through a LISN to the input power source.
- 6. The excess length of the power cord between the EUT and the LISN receptacle were folded back and forth at the center of the lead to form a bundle not exceeding 40 cm in length.
- 7. Conducted emissions were investigated over the frequency range from 0.15MHz to 30MHz using a receiver bandwidth of 9 kHz.
- 8. During the above scans, the emissions were maximized by cable manipulation.

TEST MODE:

Please refer to the clause 3.3

TEST RESULTS

 Test Line: L Level [dBµV] 70 60 50 40 30 20 10 0 150k 300k 400k 600k 800k 1M 2M 3M 4M 5M 6M 8M 10M 20M 30M Frequency [Hz] x x x MES GM1709305017_fin Frequency Level Transd Limit Margin Detector Line PΕ dB dΒμV MHz dΒμV dΒ 0.231000 48.00 10.3 14.4 QP L1GND 10.2 57 L10.433500 38.30 18.9 QΡ GND 0.636000 37.30 10.2 56 18.7 L1GND OP 0.973500 37.90 10.2 56 18.1 QP L1GND 3.034500 33.40 10.2 56 22.6 QP L1GND 13.888500 10.5 32.50 27.5 60 QP L1GND Level Transd Limit Margin Detector Line Frequency PΕ dB dΒμV MHz dΒμV dB

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0.249000

0.429000

2.040000

2.823000

5.923500

23.127000

38.40

27.30

29.10

29.80

26.50

29.10

10.3

10.2

10.2

10.2

10.3

10.7

52

47

46

46

50

50

13.4

20.0

16.9

16.2

23.5

20.9 AV

ΑV

ΑV

ΑV

AV

ΑV

L1

L1

L1

L1

L1

L1

GND

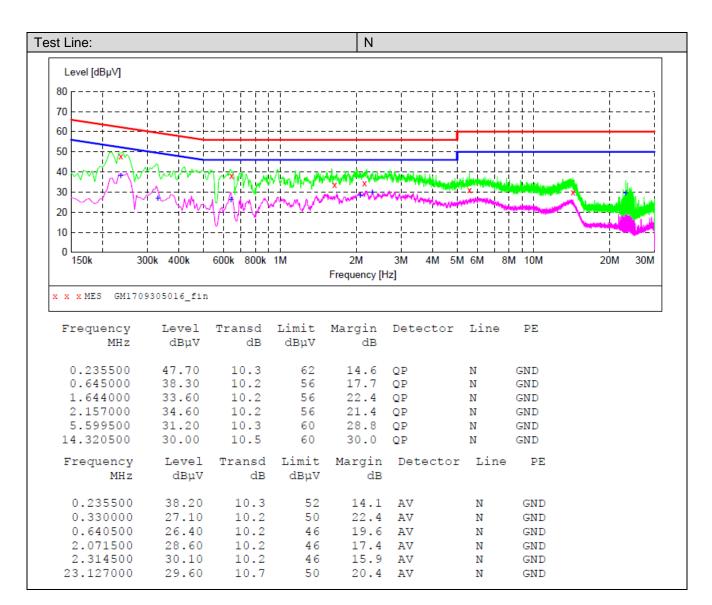
GND

GND

GND

GND

GND



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5.2. Radiated Emissions Test

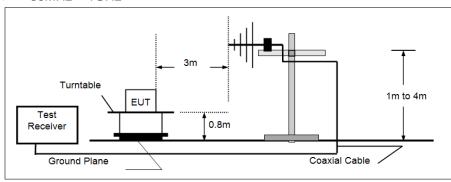
LIMIT

FCC CFR Title 47 Part 15 Subpart B Section 15.209

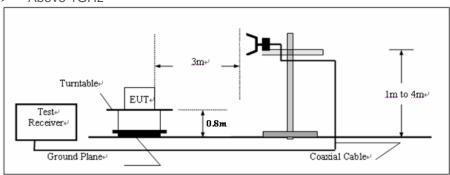
Frequency	Limit (dBuV/m @3m)	Value
30MHz-88MHz	40.00	Quasi-peak
88MHz-216MHz	43.50	Quasi-peak
216MHz-960MHz	46.00	Quasi-peak
960MHz-1GHz	54.00	Quasi-peak
Above 1GHz	54.00	Average
	74.00	Peak

TEST CONFIGURATION

➢ 30MHz ~ 1GHz



Above 1GHz



TEST PROCEDURE

- 1. The EUT was tested according to ANSI C63.4:2014.
- 2. The EUT is placed on a turn table which is 0.8 meter above ground. The turn table is rotated 360 degrees to determine the position of the maximum emission level.
- 3. The EUT waspositioned such that the distance from antenna to the EUT was 3 meters.
- 4. The antenna is scanned from 1 meter to 4 meters to find out the maximum emission level. Thisis repeated for both horizontal and vertical polarization of the antenna.
- 5. The tested frequency range 30MHz to 25GHz.
- 6. Use the following spectrum analyzer settings
 - (1) Span shall wide enough to fully capture the emission being measured;
 - (2) Below 1GHz, RBW=120KHz, VBW=300KHz, Sweep=auto, Detector function=peak, Trace=max hold;
 - If the emission level of the EUT measured by the peak detector 3 dB lower than the applicable limit, the peak emission level will be reported. Otherwise, theemission measurement will be repeated using the quasi-peak detector and reported.
 - (3) Above 1GHz, RBW=1MHz, VBW=3MHz

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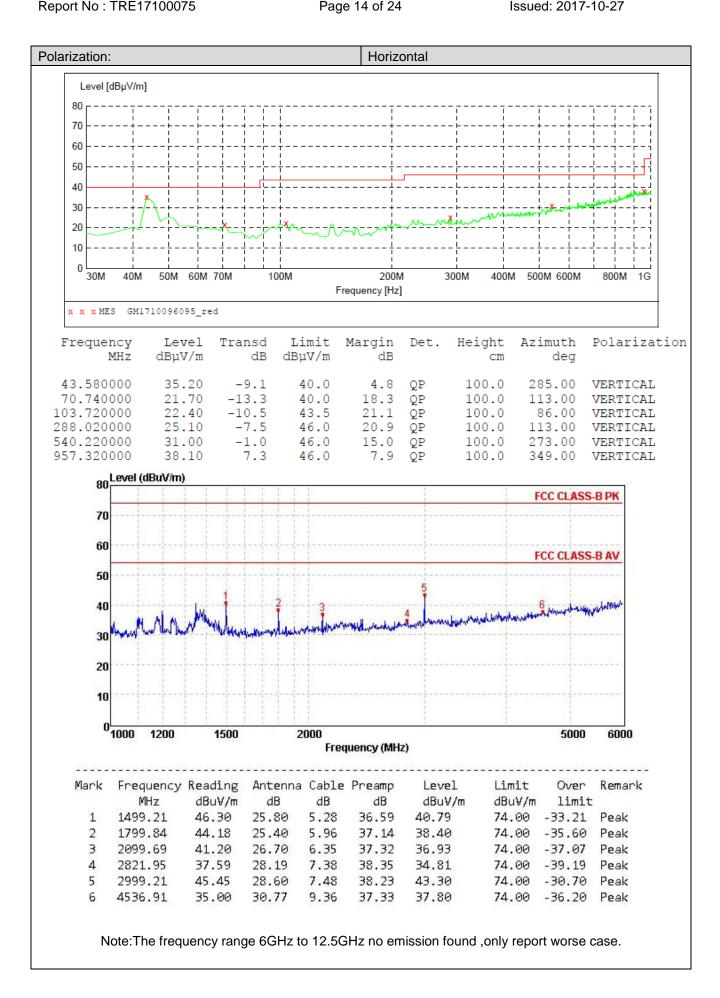
TEST MODE:
Please refer to the clause 3.3

TEST RESULTS

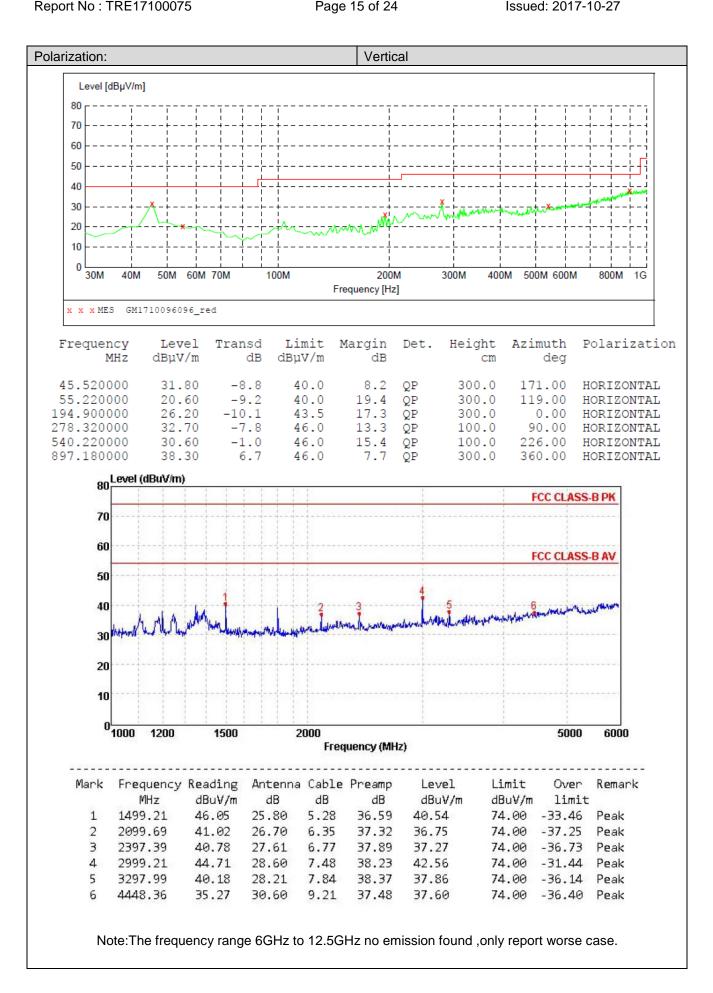
Passed Not Applicable

Note: Final Level =Receiver Read level + Antenna Factor + Cable Loss - Preamplifier Factor

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6. Test Setup Photos of the EUT

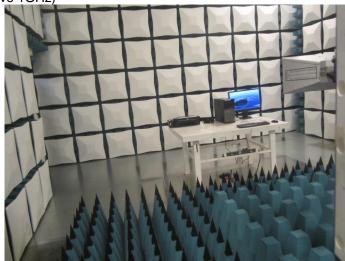
Conducted Emissions (AC Mains)



Radiated Emissions (30MHz-1GHz)



Radiated Emissions (Above 1GHz)



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7. External and Internal Photos of the EUT External Photos of the EUT















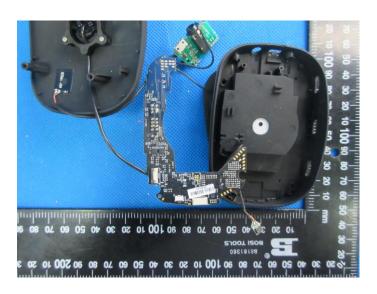
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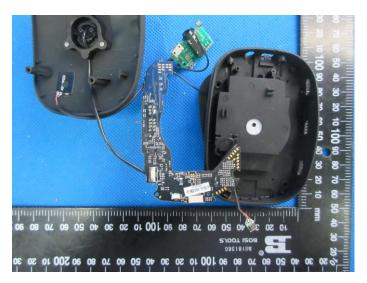
Internal Photos of the EUT



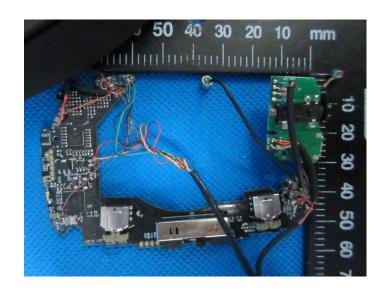


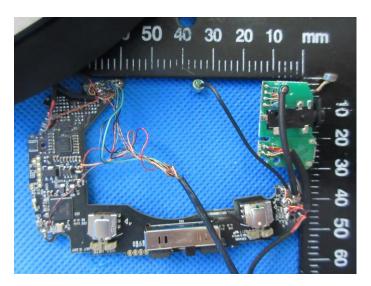


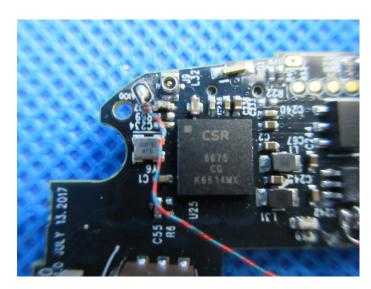


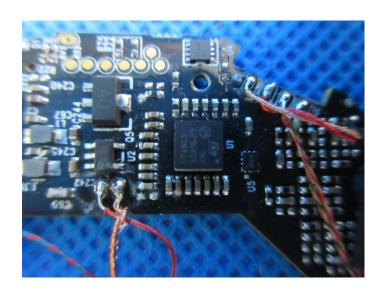


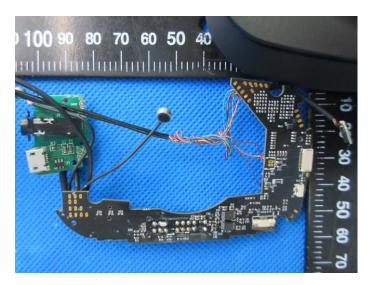


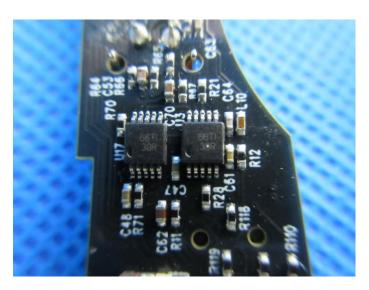


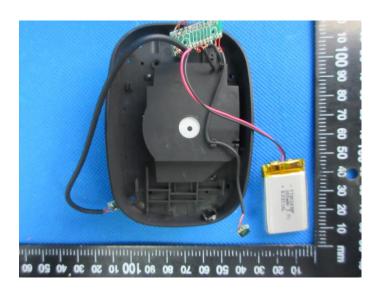
















-----End of Report-----